

$\textbf{SIPMOS}^{\circledR} \textbf{ Small-Signal-Transistor}$

Features

- Dual N- and P -Channel
- Enhancement mode
- Logic Level
- Avalanche rated
- dv/dt rated

Product Summary		N	Р	
Drain source voltage	V_{DS}	30	-30	V
Drain-Source on-state	R _{DS(on)}	0.11	0.25	Ω
resistance				
Continuous drain current	/D	3.4	-2.3	Α

Туре	Package	Ordering Code
BSO 315 C	SO 8	Q67041-S4014





Maximum Ratings,at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Value		Unit
		N	Р	
Continuous drain current	I _D			Α
T _A = 25 °C		3.4	-2.3	
T _A = 70 °C		2.7	-1.8	
Pulsed drain current	I _{D puls}	11.6	-7.2	
T _A = 25 °C				
Avalanche energy, single pulse	E _{AS}			mJ
$I_{\rm D}$ = 2.9 A, $V_{\rm DD}$ = 25 V, $R_{\rm GS}$ = 25 Ω		25	-	
$I_{\rm D}$ = -1.8 A, $V_{\rm DD}$ = -25 V, $R_{\rm GS}$ = 25 Ω		-	35	
Avalanche energy, periodic limited by T_{jmax}	E _{AR}	0.2	0.2	
Reverse diode d v /d t , T_{jmax} = 150 °C	d <i>v</i> /d <i>t</i>			kV/μs
$I_{S} = 2.9 \text{ A}, \ V_{DS} = 24 \text{ , di/d}t = 200 \text{ A/}\mu\text{s}$		6	-	
$I_{S} = -1.8 \text{ A}, \ V_{DS} = -24 \text{ , } di/dt = -200 \text{ A/}\mu\text{s}$		-	6	
Gate source voltage	V_{GS}	±20	±20	V
Power dissipation	P _{tot}	2	2	W
T _A = 25 °C				
Operating and storage temperature	T _j , T _{stg}	-55+150		°C
IEC climatic category; DIN IEC 68-1		55/150/56		

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Termal Characteristics

Parameter		Symbol	Values			Unit
			min.	typ.	max.	
Dynamic Characteristics						
Thermal resistance, junction - soldering point	N	R_{thJS}	-	-	40	K/W
(Pin 5, 6, 7, 8)	P		-	-	40	
SMD version, device on PCB:		R _{thJA}				
@ min. footprint; $t \le 10$ sec.	N		-	-	100	
@ 6 cm ² cooling area $^{1)}$; t \leq 10 sec.	N		-	-	62.5	
@ min. footprint; $t \le 10$ sec.	P		-	-	70	
@ 6 cm ² cooling area $^{1)}$; $t \le 10$ sec.	Р		-	-	62.5	
Static Characteristics , at $T_j = 25$ °C, unless other	rwise	specified				
Drain- source breakdown voltage		V _{(BR)DSS}				V
$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	N	` '	30	-	-	
$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	Р		-30	-	-	
Gate threshold voltage, $V_{GS} = V_{DS}$		V _{GS(th)}				•
$I_{\rm D} = 20 \; \mu {\rm A}$	N	` ,	1.2	1.6	2	
$I_{\rm D} = -230 \; \mu {\rm A}$	Р		-1	-1.5	-2.0	
Zero gate voltage drain current		l _{DSS}				μA
$V_{DS} = 30 \text{ V}, \ V_{GS} = 0 \text{ V}, \ T_i = 25 \text{ °C}$	N		-	0.1	1	
$V_{\rm DS} = 30 \text{ V}, \ V_{\rm GS} = 0 \text{ V}, \ T_{\rm i} = 125 \text{ °C}$	N		_	10	100	
$V_{\rm DS} = -30 \text{ V}, \ V_{\rm GS} = 0 \text{ V}, \ T_{\rm i} = 25 \text{ °C}$	Р		_	-0.1	-1	
$V_{DS} = -30 \text{ V}, \ V_{GS} = 0 \text{ V}, \ T_{j} = 125 \text{ °C}$	Р		-	-10	-100	
Gate-source leakage current		I _{GSS}				nA
$V_{GS} = 20 \text{ V}, \ V_{DS} = 0 \text{ V}$	N		-	10	100	
$V_{GS} = -20 \text{ V}, \ V_{DS} = 0 \text{ V}$	Р		-	-10	-100	
Drain-Source on-state resistance		R _{DS(on)}				Ω
$V_{GS} = 4.5 \text{ V}, I_D = 2.9 \text{ A}$	N	- (-)	-	0.1	0.15	
$V_{GS} = -4.5 \text{ V}, I_D = -1.8 \text{ A}$	Р		-	0.2	0.4	
Drain-Source on-state resistance		R _{DS(on)}				Ω
$V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$	N	(- /	-	0.06	0.11	
$V_{GS} = -10 \text{ V}$, $I_D = -2.3 \text{ A}$	Р		-	0.13	0.25	

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm ² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified

Parameter		Symbol	Values			Unit
			min.	typ.	max.	
Characteristics		•		•		
Transconductance		<i>9</i> fs				S
$V_{DS} \ge 2 * I_{D} * R_{DS(on)max}, I_{D} = 2.9 \text{ A}$	N		2.2	4.5	-	
$VV_{DS} \ge 2 * I_D * R_{DS(on)max}, I_D = -1.8 A$	Р		1.6	3.2	-	
Input capacitance		C _{iss}				pF
$V_{GS} = 0 \text{ V}, \ V_{DS} = 25 \text{ V}, \ f = 1 \text{ MHz}$	N		-	200	250	
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$	Р		-	200	250	
Output capacitance		Coss				
$V_{GS} = 0 \text{ V}, \ V_{DS} = 25 \text{ V}, \ f = 1 \text{ MHz}$	N		-	93	116	
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$	Р		-	113	140	
Reverse transfer capacitance		C _{rss}				
$V_{GS} = 0 \text{ V}, \ V_{DS} = 25 \text{ V}, \ f = 1 \text{ MHz}$	N		-	50	63	
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$	Р		-	38	48	
Turn-on delay time		<i>t</i> d(on)				ns
$V_{\rm DD}$ = 15 V, $V_{\rm GS}$ = 4.5 V, $I_{\rm D}$ = 2.9 A, $R_{\rm G}$ = 33 Ω	N		-	15	22	
$V_{\rm DD}$ = -15 V, $V_{\rm GS}$ = -4.5 V, $I_{\rm D}$ = -1.8 A, $R_{\rm G}$ = 24 Ω	Р		-	22	33	
Rise time		t _r				
$V_{\rm DD}$ = 15 V, $V_{\rm GS}$ = 4.5 V, $I_{\rm D}$ = 2.9 A, $R_{\rm G}$ = 33 Ω	N		-	96	144	
$V_{\rm DD}$ = -15 V, $V_{\rm GS}$ = -4.5 V, $I_{\rm D}$ = -1.8 A, $R_{\rm G}$ = 24 Ω	Р		-	71	107	
Turn-off delay time		<i>t</i> d(off)				
$V_{\rm DD}$ = 15 V, $V_{\rm GS}$ = 4.5 V, $I_{\rm D}$ = 2.9 A, $R_{\rm G}$ = 33 Ω	N		-	13	20	
$V_{\rm DD}$ = -15 V, $V_{\rm GS}$ = -4.5 V, $I_{\rm D}$ = -1.8 A, $R_{\rm G}$ = 24 Ω	Р		-	56	84	
Fall time		<i>t</i> _f				
$V_{\rm DD}$ = 15 V, $V_{\rm GS}$ = 4.5 V, $I_{\rm D}$ = 2.9 A, $R_{\rm G}$ = 33 Ω	N		-	20	30	
$V_{\rm DD}$ = -15 V, $V_{\rm GS}$ = -4.5 V, $I_{\rm D}$ = -1.8 A, $R_{\rm G}$ = 24 Ω	Р		-	61	90	

BSO 315 C

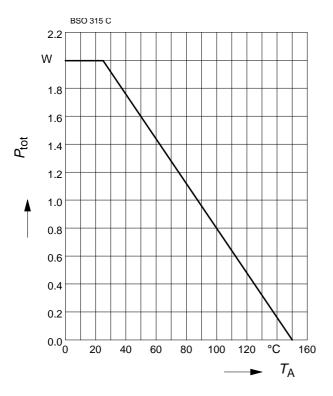
Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified

Parameter		Symbol	Values			Unit
			min.	typ.	max.	
Characteristics			•	•	•	•
Gate to source charge		Q_{gs}				nC
$V_{\rm DD} = 24 \text{ V}, I_{\rm D} = 3.4 \text{ A}$	N		-	1.1	1.6	
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -2.3 A	P		-	1.1	1.6	
Gate to drain charge		$Q_{\rm gd}$				
$V_{\rm DD} = 24 \text{ V}, I_{\rm D} = 3.4 \text{ A}$	N		-	3.3	5	
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -2.3 A	Р		-	2.1	3.2	
Gate charge total		Q_g				
$V_{\rm DD}$ = 24 V, $I_{\rm D}$ = 3.4 A, $V_{\rm GS}$ = 0 to 10V	N		-	7.8	11.7	
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -2.3 A, $V_{\rm GS}$ = 0 to -10V	P		-	7	10	
Gate plateau voltage		V _(plateau)				٧
$V_{\rm DD} = 24 \text{ V}, I_{\rm D} = 3.4 \text{ A}$	N		-	3.5	-	
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -2.3 A	Р		-	-2.8	-	
Reverse Diode						
Inverse diode continuous forward current	N	I _S	-	-	2.9	Α
$T_{A} = 25 ^{\circ}\text{C}$	P		-	-	-1.8	
Inverse diode direct current,pulsed	N	I _{SM}	-	-	11.6	
$T_A = 25 ^{\circ}\text{C}$	Р		-	-	-7.2	
Inverse diode forward voltage		V_{SD}				V
$V_{GS} = 0 \text{ V}, I_{F} = I_{S}$	N		-	0.85	1.1	
$V_{GS} = 0 \text{ V}, I_{F} = I_{S}$	P		-	-0.85	-1.1	
Reverse recovery time		<i>t</i> _{rr}				ns
$V_{R} = 15 \text{ V}, I_{F} = I_{S}, di_{F}/dt = 100 \text{ A/}\mu\text{s}$	N		-	25	38	
$V_{R} = -15 \text{ V}, I_{F}=I_{S}, di_{F}/dt = -100 \text{ A/}\mu\text{s}$	Р		-	60	90	
Reverse recovery charge		Q _{rr}				μC
$V_{R} = 15 \text{ V}, I_{F} = I_{S}, dI_{F}/dt = 100 \text{ A/}\mu\text{s}$	N		-	12	18	
$V_{R} = -15 \text{ V}, I_{F} = I_{S}, di_{F}/dt = -100 \text{ A/}\mu\text{s}$	Р		-	37	55	



Power Dissipation (N-Ch.)

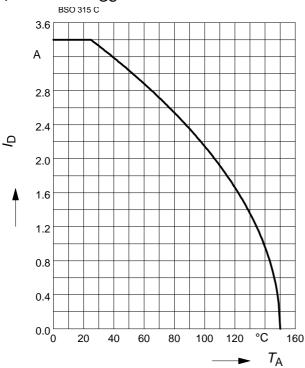
$$P_{\text{tot}} = f(T_{A})$$



Drain current (N-Ch.)

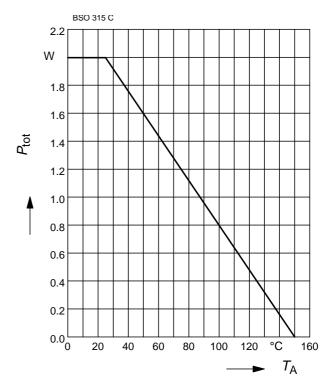
$$I_{D} = f(T_{A})$$

parameter: V_{GS}≥ 10 V



Power Dissipation (P-Ch.)

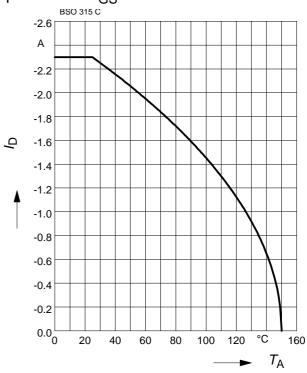
$$P_{\text{tot}} = f(T_{A})$$



Drain current (P-Ch.)

$$I_{D} = f(T_{A})$$

parameter: $V_{GS} \ge -10 \text{ V}$



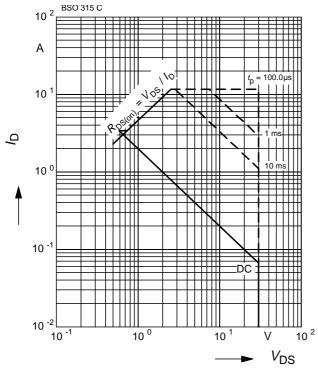
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Safe operating area (N-Ch.)

$$I_{D} = f(V_{DS})$$

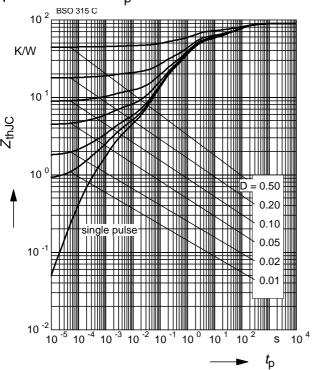
parameter : D = 0 , $T_A = 25$ °C



Transient thermal impedance (N-Ch.)

$$Z_{\text{thJC}} = f(t_{\text{p}})$$

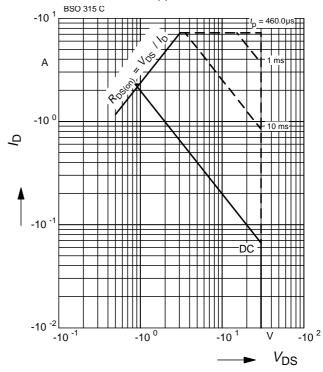
parameter : $D = t_D/T$



Safe operating area (P-Ch.)

$$I_{D} = f(V_{DS})$$

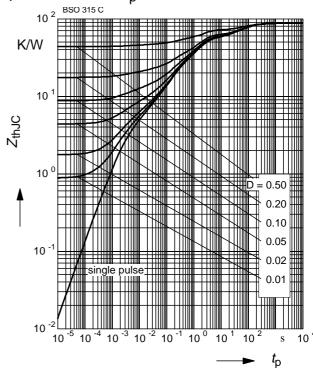
parameter : D = 0 , $T_A = 25$ °C



Transient thermal impedance (P-Ch.)

$$Z_{\text{thJC}} = f(t_{\text{D}})$$

parameter : $D = t_D/T$



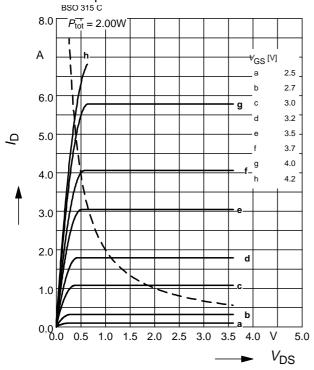
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Typ. output characteristics (N-Ch.)

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

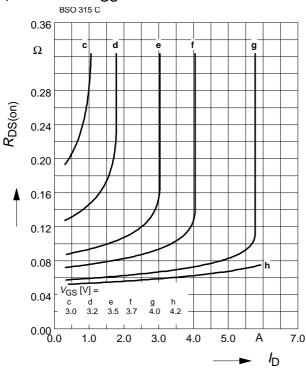
parameter: $t_p = 80 \mu s$



Typ. drain-source-on-resistance (N-Ch.)

$$R_{\mathrm{DS(on)}} = f(I_{\mathrm{D}})$$

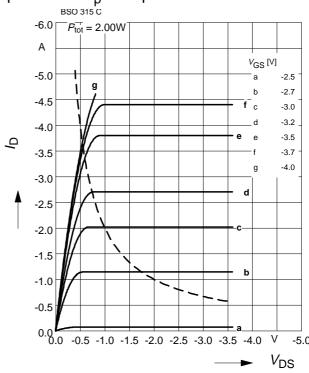
parameter: V_{GS}



Typ. output characteristics (P-Ch.)

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

parameter: $t_p = 80 \mu s$

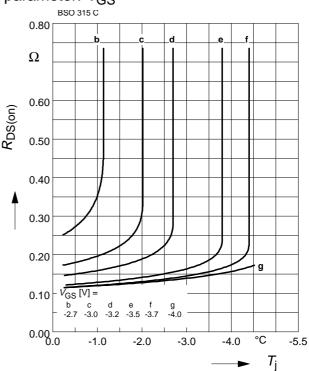


Typ. drain-source-on-resistance (P-Ch.)

 $R_{\mathrm{DS(on)}} = f(I_{\mathrm{D}})$

parameter: V_{GS}

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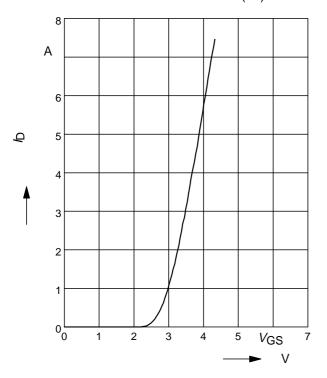
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Typ. transfer characteristics (N-Ch.)

parameter: $t_p = 80 \mu s$

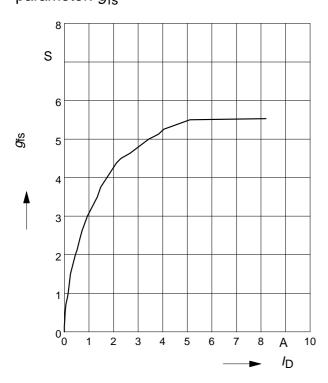
$$I_D = f(V_{GS}), V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$$



Typ. forward transconductance (N-Ch.)

$$g_{fs} = f(I_D); T_j = 25 \text{ °C}$$

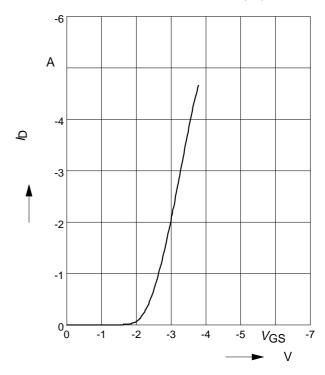
parameter: g_{fs}



Typ. transfer characteristics (P-Ch.)

parameter: $t_p = 80 \mu s$

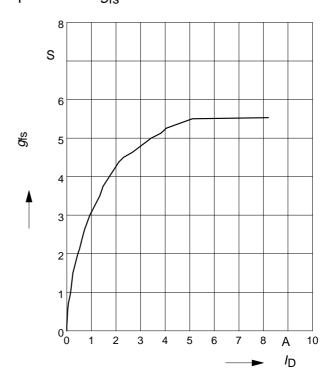
$$I_{D} = f(V_{GS}), V_{DS} \ge 2 \times I_{D} \times R_{DS(on)max}$$



Typ. forward transconductance (P-Ch.)

$$g_{fs} = f(I_D); T_j = 25 \text{ °C}$$

parameter: gfs



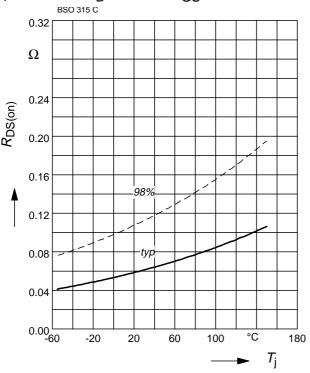
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Drain-source on-resistance (N-Ch.)

$$R_{DS(on)} = f(T_i)$$

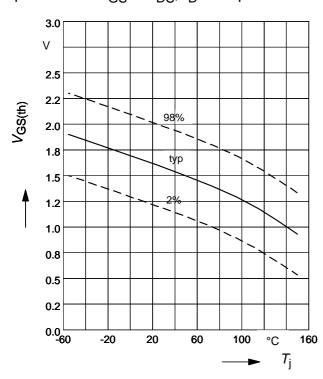
parameter :
$$I_D = 3.4 \text{ A}$$
, $V_{GS} = 10 \text{ V}$



Gate threshold voltage (N-Ch.)

$$V_{GS(th)} = f(T_j)$$

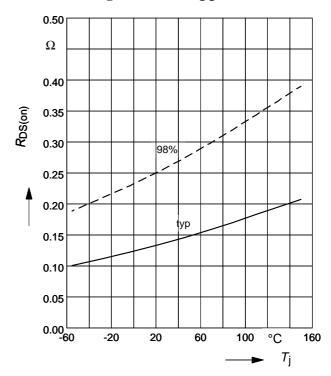
parameter:
$$V_{GS} = V_{DS}$$
, $I_D = 20 \mu A$



Drain-source on-resistance (P-Ch.)

$$R_{DS(on)} = f(T_i)$$

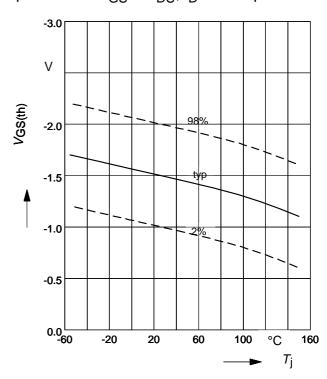
Parameter:
$$I_D$$
 = -2.3 A, V_{GS} = -10 V



Gate threshold voltage (P-Ch.)

$$V_{GS(th)} = f(T_i)$$

parameter:
$$V_{GS} = V_{DS}$$
, $I_D = -230 \mu A$



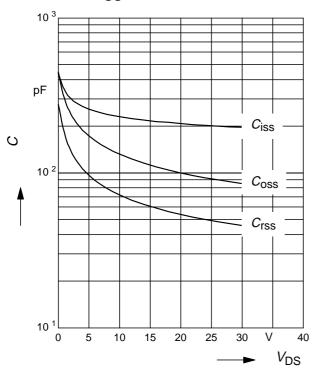
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Typ. capacitances (N-Ch.)

 $C = f(V_{DS})$

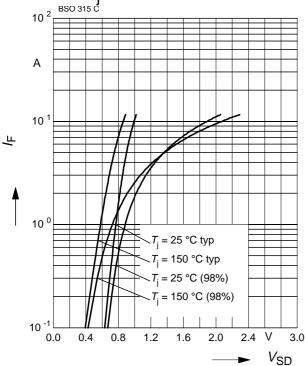
parameter: $V_{GS}=0$ V, f=1 MHz



Forward characteristics of reverse diode

 $I_{\mathsf{F}} = f(\mathsf{V}_{\mathsf{SD}}), (\mathsf{N}\text{-}\mathsf{Ch}.)$

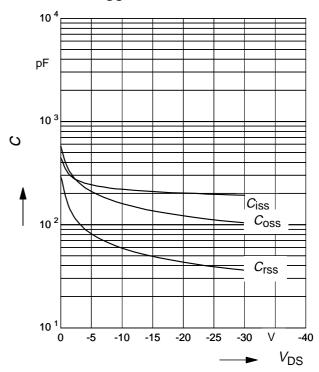
parameter: T_i , tp = 80 μ s



Typ. capacitances (P-Ch.)

 $C=\mathsf{f}(V_{\mathsf{DS}})$

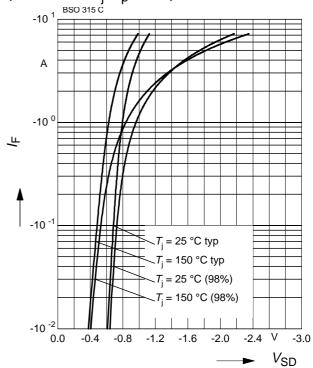
parameter: $V_{GS}=0$ V, f=1 MHz



Forward characteristics of reverse diode

 $I_{\mathsf{F}} = f(V_{\mathsf{SD}}), (\mathsf{P}\text{-}\mathsf{Ch}.)$

parameter: T_i , $t_p = 80 \mu s$



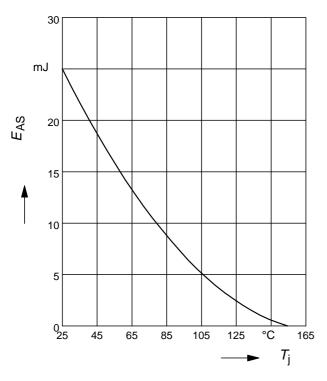
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Avalanche Energy $E_{AS} = f(T_j)$ (N-Ch.)

parameter: $I_D = 2.9 \text{ A}$, $V_{DD} = 25 \text{ V}$

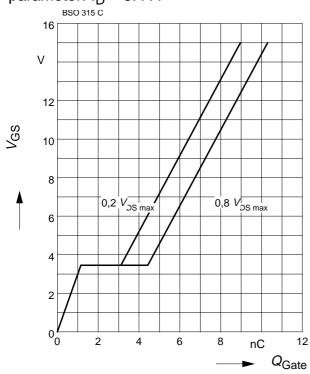
 $R_{\rm GS} = 25~\Omega$



Typ. gate charge (N-Ch.)

 $V_{GS} = f (Q_{Gate})$

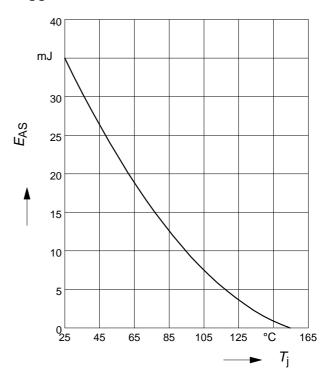
parameter: $I_D = 3.4 \text{ A}$



Avalanche Energy $E_{AS} = f(T_i)$

parameter: $I_D = -1.8 \text{ A}$, $V_{DD} = -25 \text{ V}$

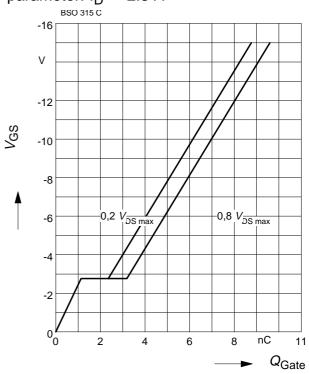
 $R_{\rm GS}$ = 25 Ω



Typ. gate charge (P-Ch.)

 $V_{GS} = f (Q_{Gate})$

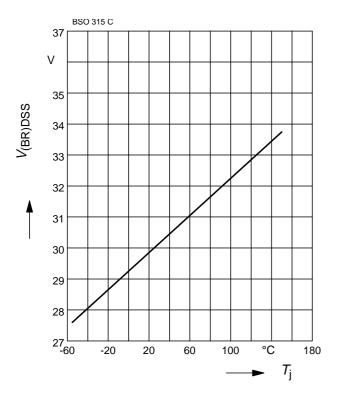
parameter: $I_D = -2.3 \text{ A}$



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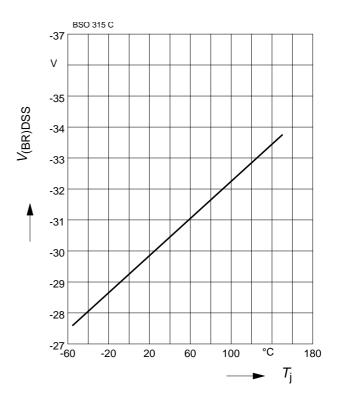
Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), (N-Ch.)$$



Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), (P-Ch.)$$





Preliminary data

BSO 315 C

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